

Disordered Quantum Wires*

Thomas Nattermann

Universität zu Köln

Thierry Giamarchi

Geneva

Pierre Le Doussal

Paris

Bernd Rosenow

Köln/Harvard

Sergey Malinin

Köln/Detroit

Michel Fogler

UCSD

* $e=h=k_B=1$

- Electrons in 3 dimensions
- Electrons in 1 dimension: what is different?
- Electrons in 1 dimension: experiments
- Quantum wire as a chain of quantum dots
- Long wires: Rare events
- Conclusions

1. Electrons in three dimensions

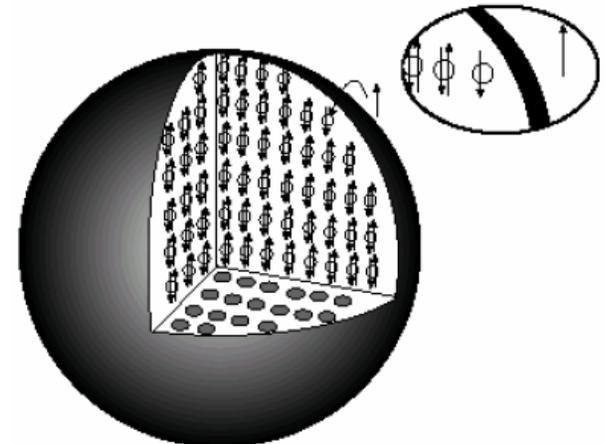
Non-interacting electrons: mass m , mean spacing a , Planck's constant \hbar

→ energy scale $\hbar^2/ma^2 \sim E_F$

$T \ll E_F$: Pauli principle determines pressure → $p \sim \hbar^2/ma^{d+2}$

Compressibility*: $\kappa = -a^{-2d} \partial \ln V / \partial p \sim 1/(E_F a^d)$

Specific heat: $C \sim T/E_F$



1. Electrons in three dimensions

Interacting spinless electrons:

charge $e \rightarrow$ strength of interaction $\sim (e^2/a) / E_F \sim a/a_B !$

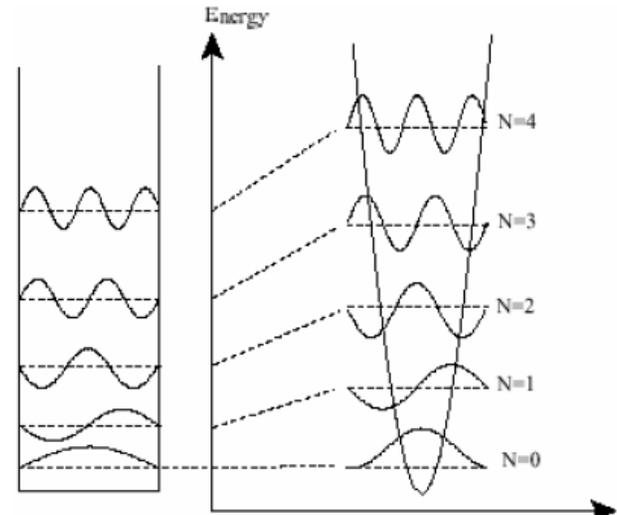
but energy and momentum conservation reduce phase space

\Rightarrow Landau's Fermi fluid of quasi-particles

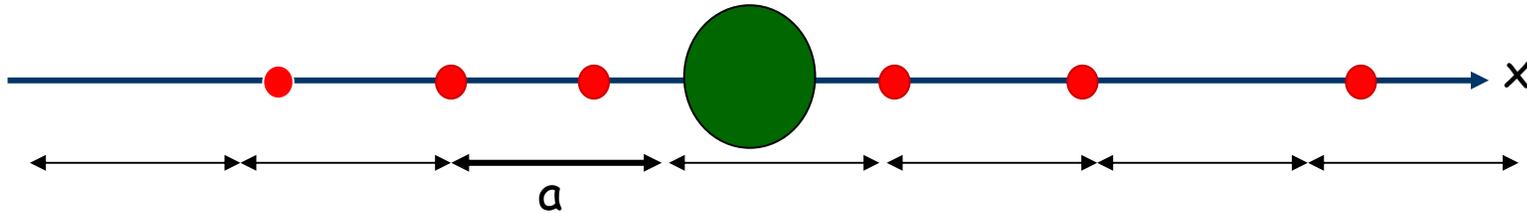
with finite lifetime $\hbar/\tau \sim E_F(T/E_F)^2$

Disordered spinless electrons:

Metal insulator transition



2. Electrons in one dimension - what is different?



Electrons cannot avoid each other \rightarrow Landau's picture breaks down

\Rightarrow density wave excitations : plasmons

(a) 1D clean wire: Luttinger liquid $G = dJ/dV = \sigma/L = (K) e^2/h$

(b)+ **single impurity** : $K < 1$: impurity relevant, $\rightarrow G \sim (\max(T, eV))^{2/K-2}$
Kane & Fisher '92, Furusaki & Nagaosa

$K > 1$: impurity irrelevant

K

3. Electrons in one dimension: Experiments

• MoSe Nanowires

Venkataraman,
PRL (2006)

$$J / T^{\alpha+1} \sim \max (V/T, V^{\beta+1}/T^{\alpha+1})$$

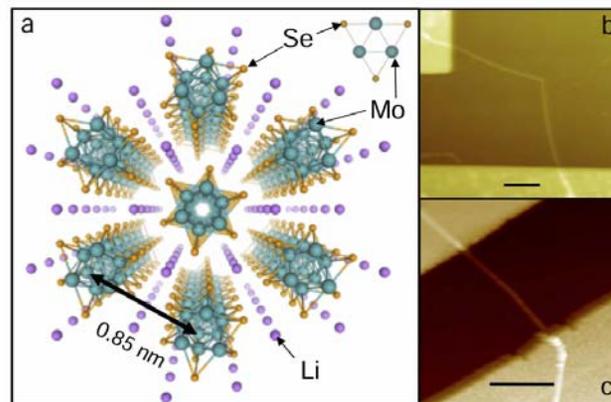
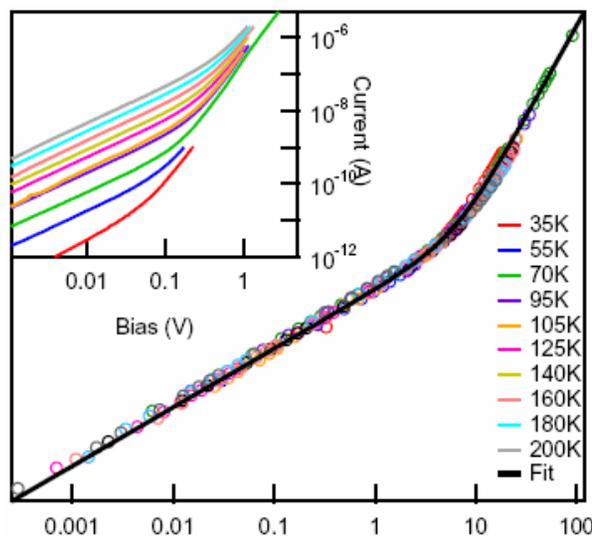


FIG. 1 (color online). (a) Structural model of a 7-chain MoSe nanowire along with the triangular Mo_3Se_3 unit cell. (b) and (c) AFM height images of MoSe nanowires between two Au electrodes. The wire heights are 7.2 nm and 12.0 nm, respectively. Scale bar = 500 nm.

$$\frac{J}{T^{\alpha+1}}$$



$$\frac{\text{Voltage}}{\text{Temperature}}$$

short wires ($L \sim 1 \mu\text{m}$):

“Temperature” Exponent (a) is close to “Voltage” Exponent (b)

Agrees with the conventional “Luttinger-liquid” picture with

$$\alpha = \beta = 2/K - 2$$

3. Electrons in one dimension: Experiments

• Multiwall carbon nanotubes

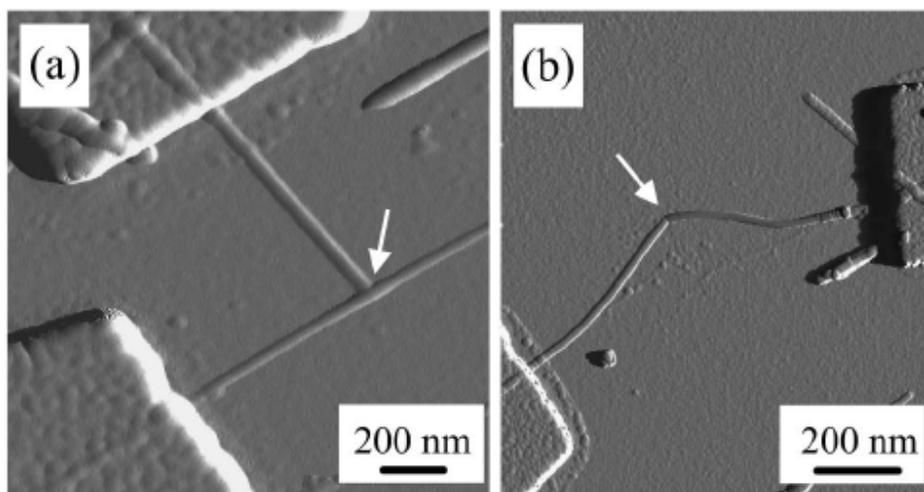
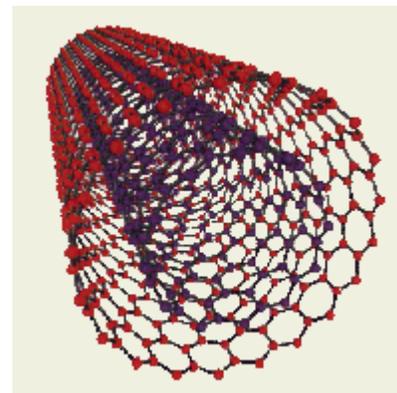
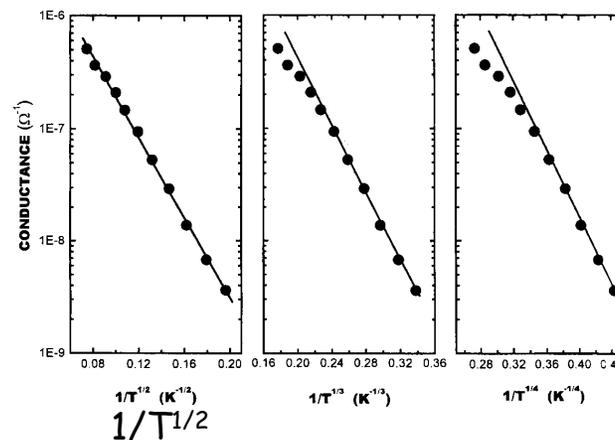


FIG. 3. AFM images of junctions formed between two MWNTs: (a) end-bulk junction and (b) end-end junction. The arrows indicate the position of the junctions.

conductance



$$J \sim e^{-(T_0/T)^{1/2}}$$

3. Electrons in one dimension: Experiments

Variable Range Hopping conduction in polydiacetylene single crystals

A. N. Aleshin*

*School of Physics and Condensed Matter Research Institute, Seoul National University, Seoul 151-747, Korea
and A. F. Ioffe Physical-Technical Institute, Russian Academy of Sciences, St. Petersburg 194021, Russia*

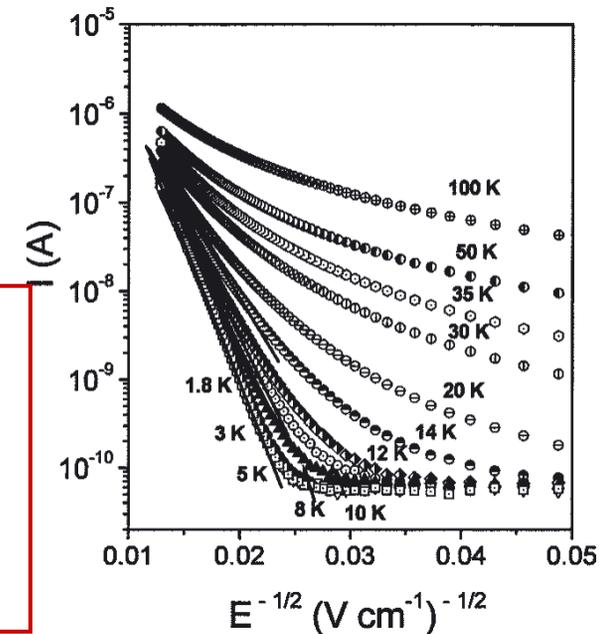
J. Y. Lee, S. W. Chu, S. W. Lee, B. Kim, S. J. Ahn, and Y. W. Park

School of Physics and Condensed Matter Research Institute, Seoul National University, Seoul 151-747, Korea

$T_0(\text{K})$	$E_0(\text{V/cm})$
2.57×10^3	4.9×10^5
2.47×10^3	3.2×10^5
4.72×10^3	1.1×10^6

$$J \sim e^{-(E_0/E)^{1/2}}$$

The charge transport in polydiacetylene quasi-1D single crystals (PDA-PTS) has been studied as a function of temperature, electric and magnetic fields. In the Ohmic regime the temperature dependence of the resistivity, $\rho(T)$, is characteristic of hopping conduction with a crossover at $T < 50$ K from activated $\rho(T) = \rho_0 \exp[(E_A/k_B T)]$, with $E_A \sim 13$ – 19 meV to variable-range hopping transport $\rho(T) = \rho_0 \exp[(T_0/T)^p]$, with $p \sim 0.65$ – 0.70 . At modest electric fields the resistivity depends as $\rho(E, T) = \rho(0, T) \exp(-eEL/k_B T)$, where the characteristic hopping length changes as $L \sim T^{-m}$ with $m \sim 0.5$ at $T > 50$ K and $m \sim 0.75$ at $T < 50$ K. At high electric fields the low temperature current becomes temperature independent and follows: $I(E) = I_0 \exp[-(E_0/E)^{0.5}]$, which corresponds to the regime of activation-free phonon-emission-assisted hopping



3. Electrons in one dimension: Experiments

• Polymer nanofibers

long wires: 10 μ m

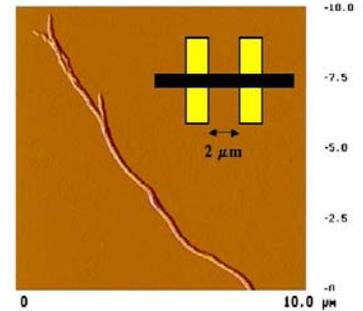
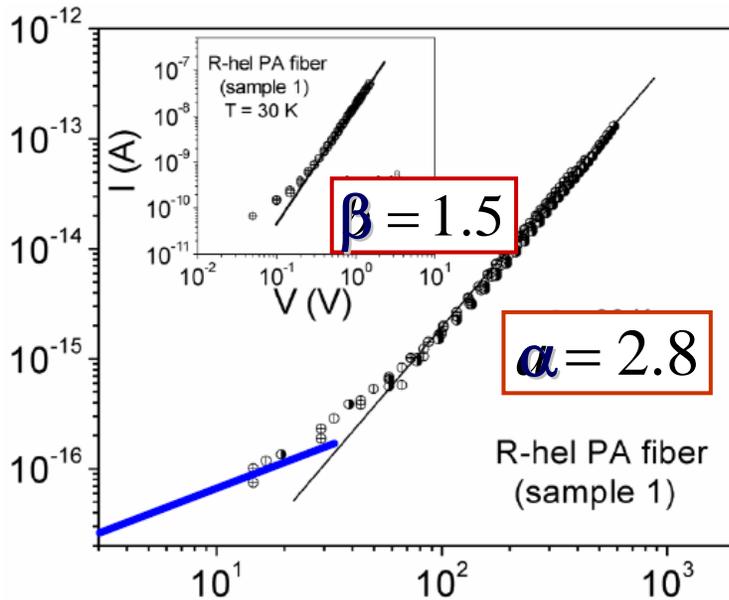


FIG. 1 (color online). AFM image of a R-hel PA fiber; the inset shows the schematic of a two-probe device based on such a R-hel PA fiber on top of Pt electrodes.



$$\frac{I}{T^{\alpha+1}}$$

"temperature" exponent **exceeds**
"voltage" exponent!

$$J / T^{\alpha+1} \sim \max (V/T, V^{\beta+1}/T^{\alpha+1})$$

Aleshin et al.,
PRL (2004)

$$\frac{\text{Voltage}}{\text{Temperature}}$$

Disagrees with the conventional
Luttinger-liquid picture

3. Electrons in one dimension: Experiments

Observed Power-Law Exponents

L ~10 μm polymers
Aleshin et al.,
PRL (2004)

Sample	1	2	3	4	5	6
α	2.8	5.5	7.2	5.6	5.0	4.1
β	1.5	3.8	4.7	1.0	1.1	1.8

L ~ 100 μm InSb wires
Zaitsev-Zotov et al.,
JPCM (2000)

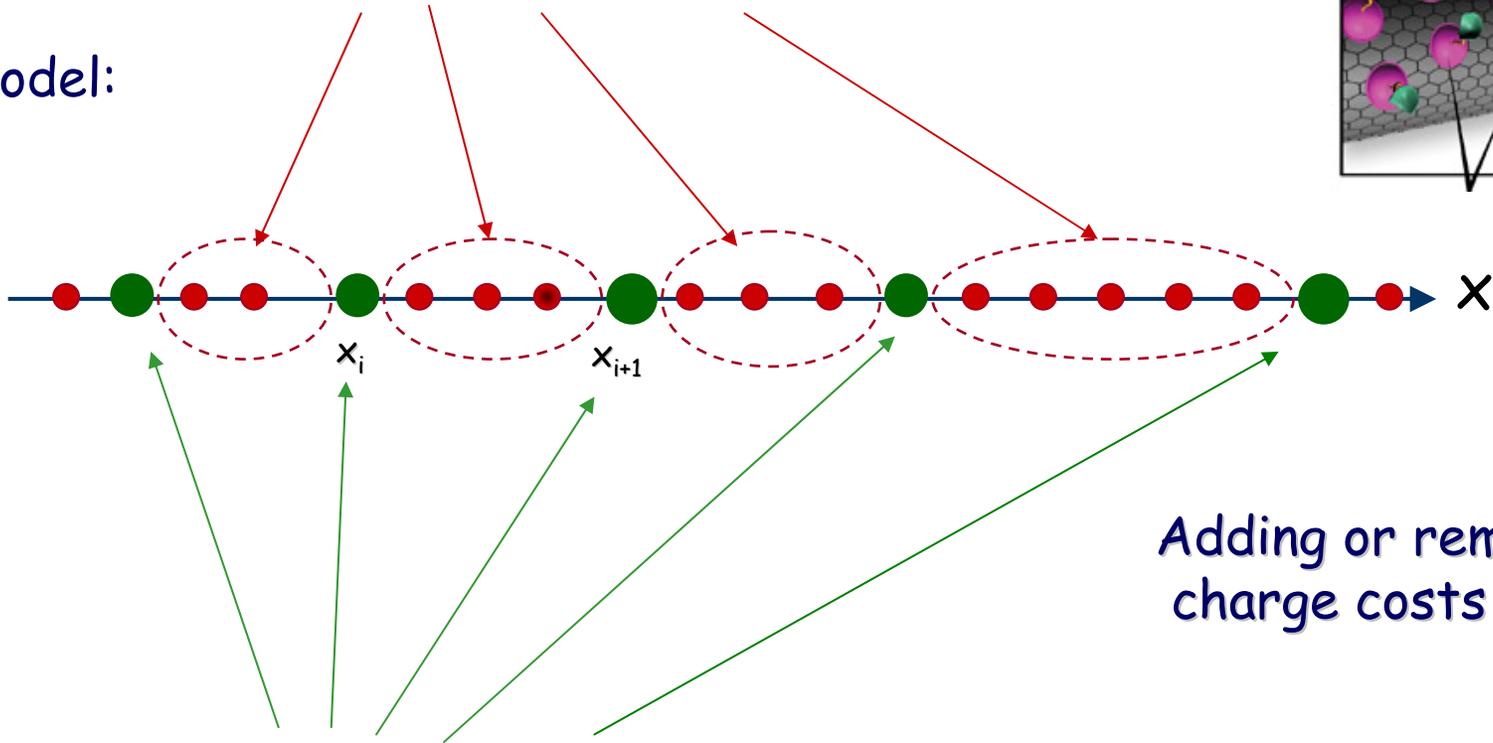
Sample	1	2	3	4
α	2.3	3.4	4.5	4.6
β	1.3	3.4	2.8	2.0

- In long wires T-exponent exceeds V-exponent: $\alpha > \beta$
- Exponents are sample-dependent

4. Quantum wire as a chain of quantum dots

"quantum dots" with integer number of electrons

Model:



Adding or removing a charge costs energy!

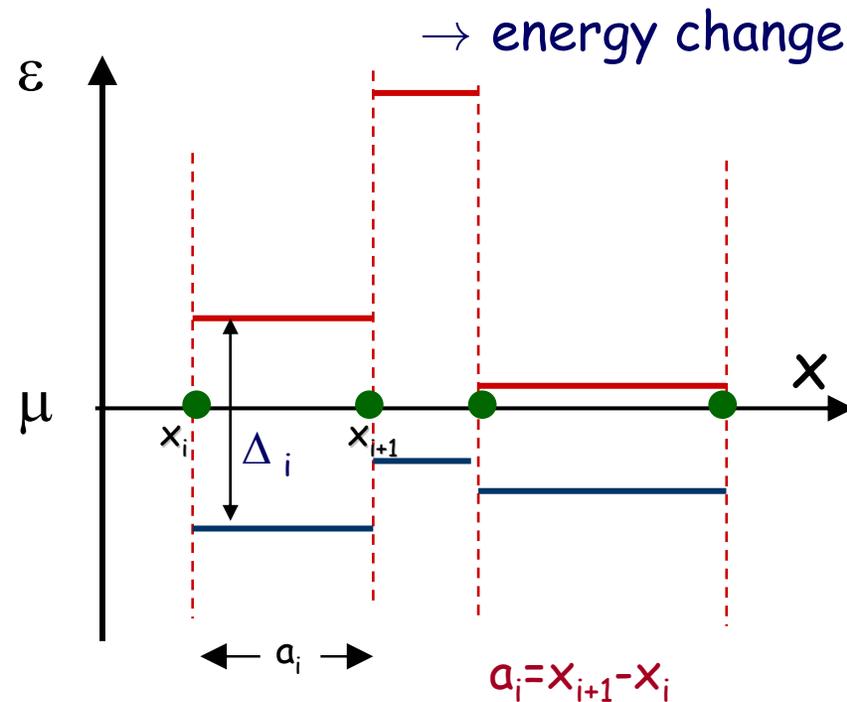
strong impurities, randomly (Poissonian) distributed

$V=0$: classical ground state ($K \ll 1$)

integer number q_i of electrons between impurities i and $i+1$

$$q_i = [Q_i]_G, \quad Q_i = a_i (2\pi k_F + \mu C) \text{ background charge}$$

excited states: change number of electrons by n_i



$$E_i(n_i) = \Delta_i \left\{ \frac{1}{2} n_i^2 + n_i (q_i - Q_i) \right\}$$

$$\Delta_i = 1 / (C a_i) \quad \text{charging energy of quantum dot}$$

C : capacitance/unit length

$$\Delta = 1 / Ca$$

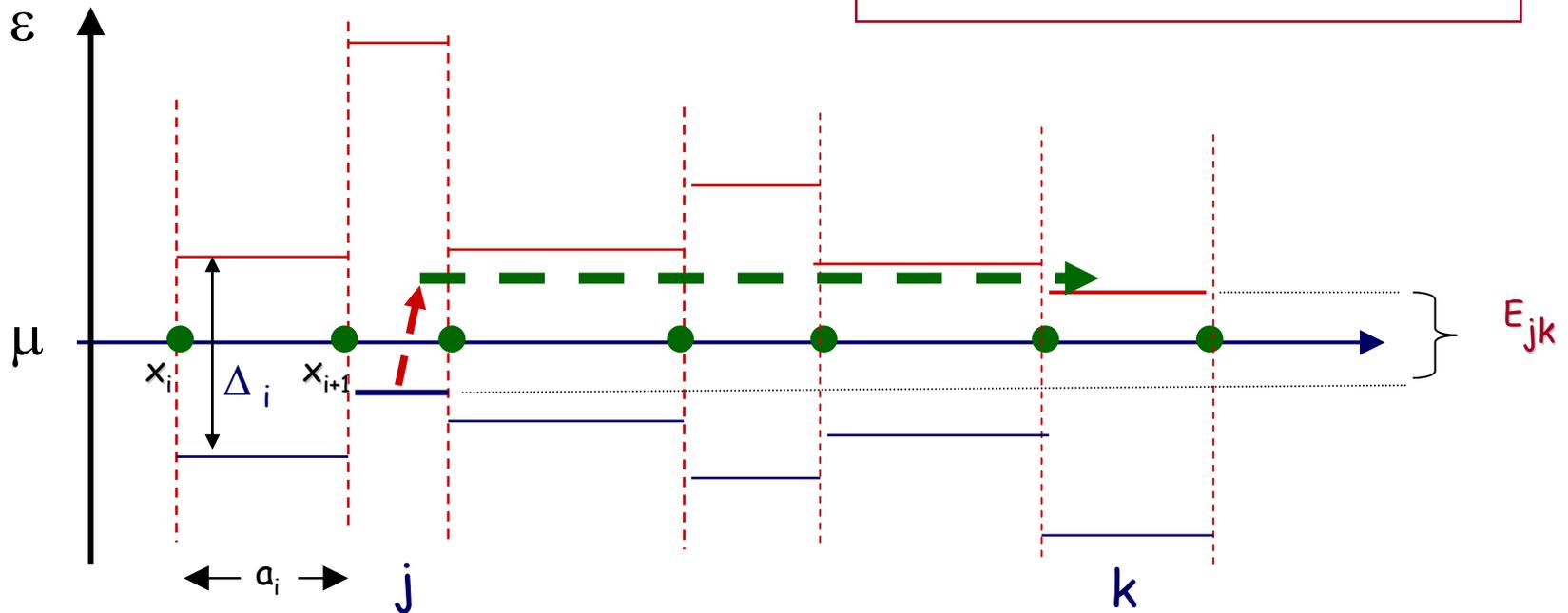
Transport from dot j to dot k by **activation** and co-tunneling

$$J_{jk} \sim e^{-E_{jk}/T} e^{-s|k-j|} \sinh((\xi_k - \xi_j)/T)$$

local electro-chemical potential $\xi_j = Fx_j - \mu_j$

tunneling transparency

$$s = 2(K^{-1} - 1) \ln(ak_F) \quad \text{Larkin, Lee '78}$$



Transport from dot j to dot k by activation and co-tunneling

$$J_{jk} \sim e^{-E_{jk}/T} e^{-s|k-j|} \sinh((\xi_k - \xi_j)/T)$$

Ohmic regime

typical energy mismatch $E_{jk} \sim \Delta / |k-j| \rightarrow |k-j| \sim (\Delta/Ts)^{1/2} \equiv x_{VRH}/a$

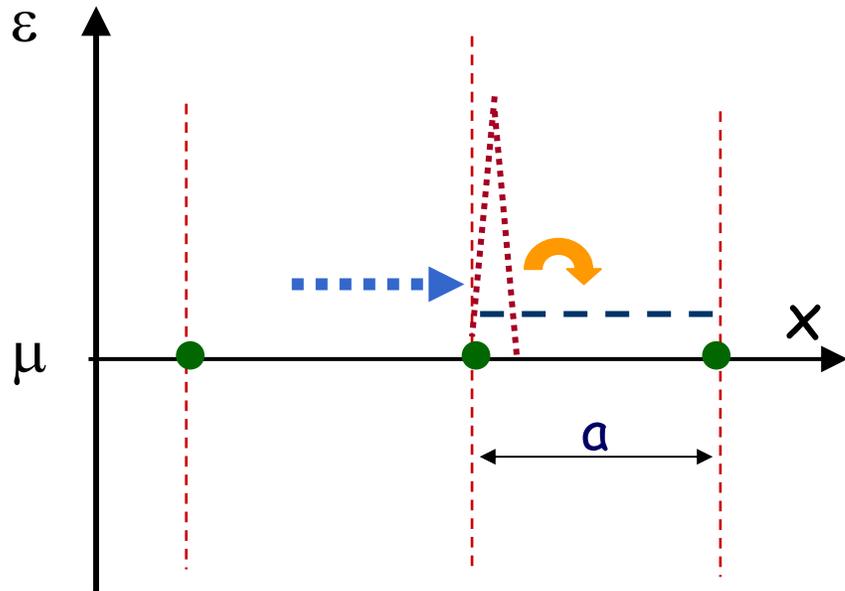
$$\Rightarrow J \sim e^{(s\Delta/T)^{1/2}} F, \quad Ts \ll \Delta \quad VRH$$

Non-ohmic regime

typical $|k-j|aF \sim \Delta / |k-j| \rightarrow |k-j| \sim (\Delta/aF)^{1/2}$

$$\Rightarrow J \sim e^{s(\Delta/aF)^{1/2}}, \quad aF \ll \Delta \quad VRH$$

Large Voltage/temperature: power laws



Larkin and Lee '78

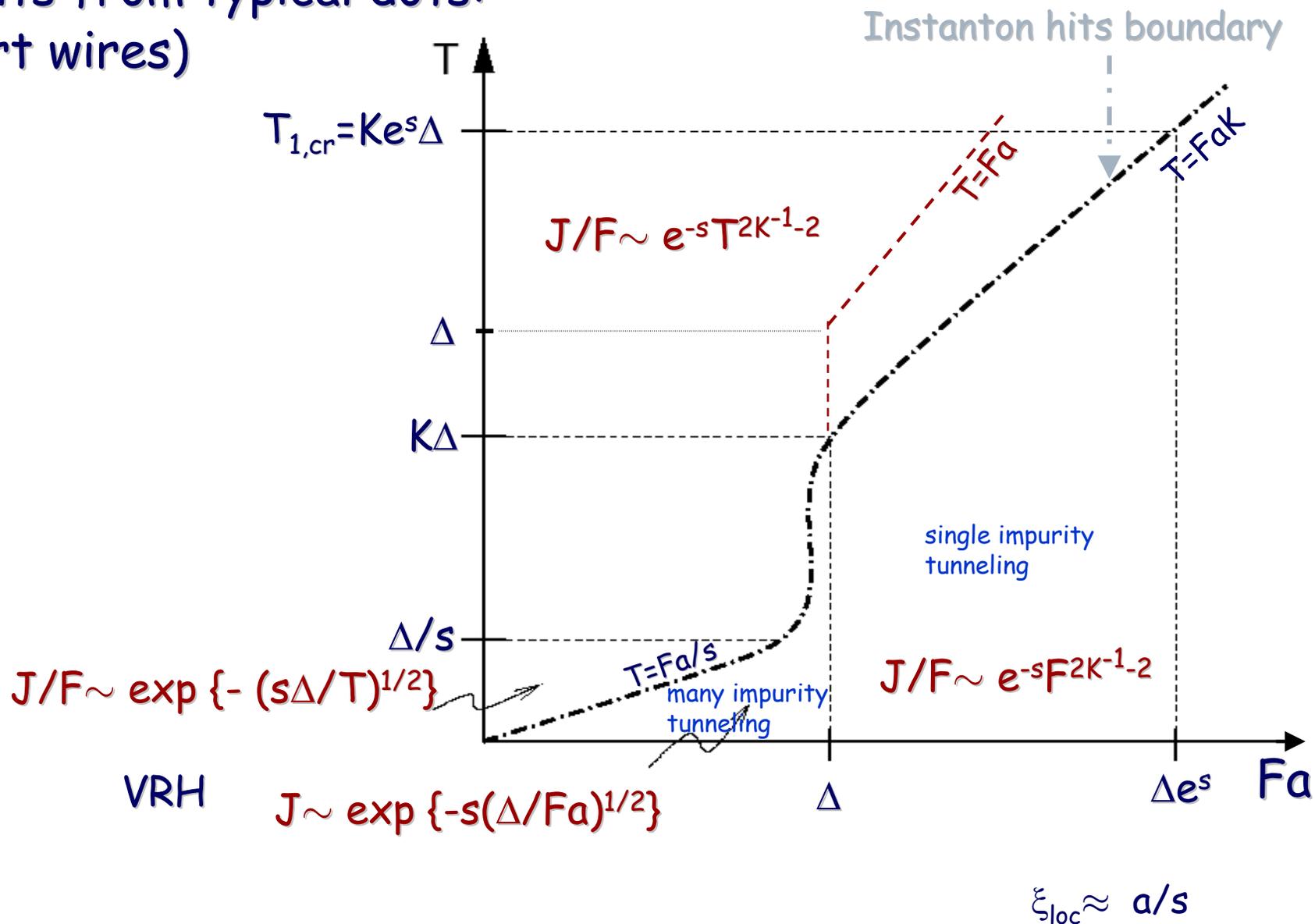
Tunneling action dominated by spreading of charge:

$$S_{\text{tun}} \sim \int d\tau E(\tau) \sim \int d\tau (C x(\tau))^{-1} \sim K^{-1} \ln (E_{\text{initial}}/E_{\text{final}})$$

$$E_{\text{initial}} = k_F / C$$

$$E_{\text{final}} = \max(\Delta, T, V)$$

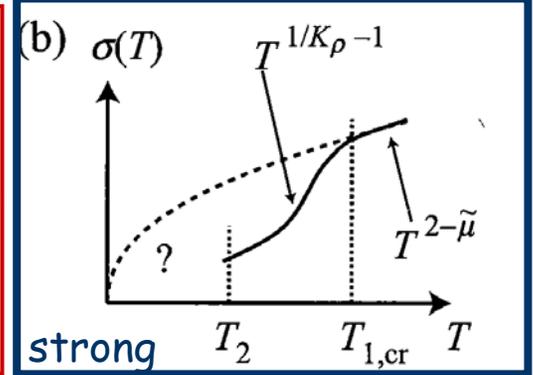
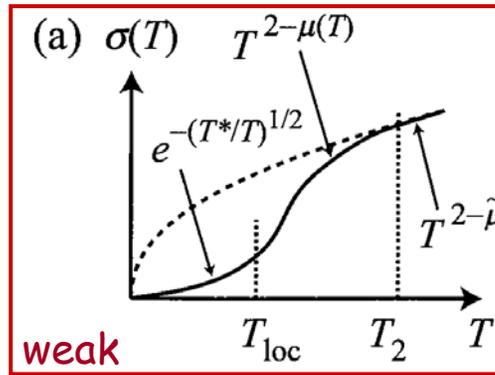
Results from typical dots: (short wires)



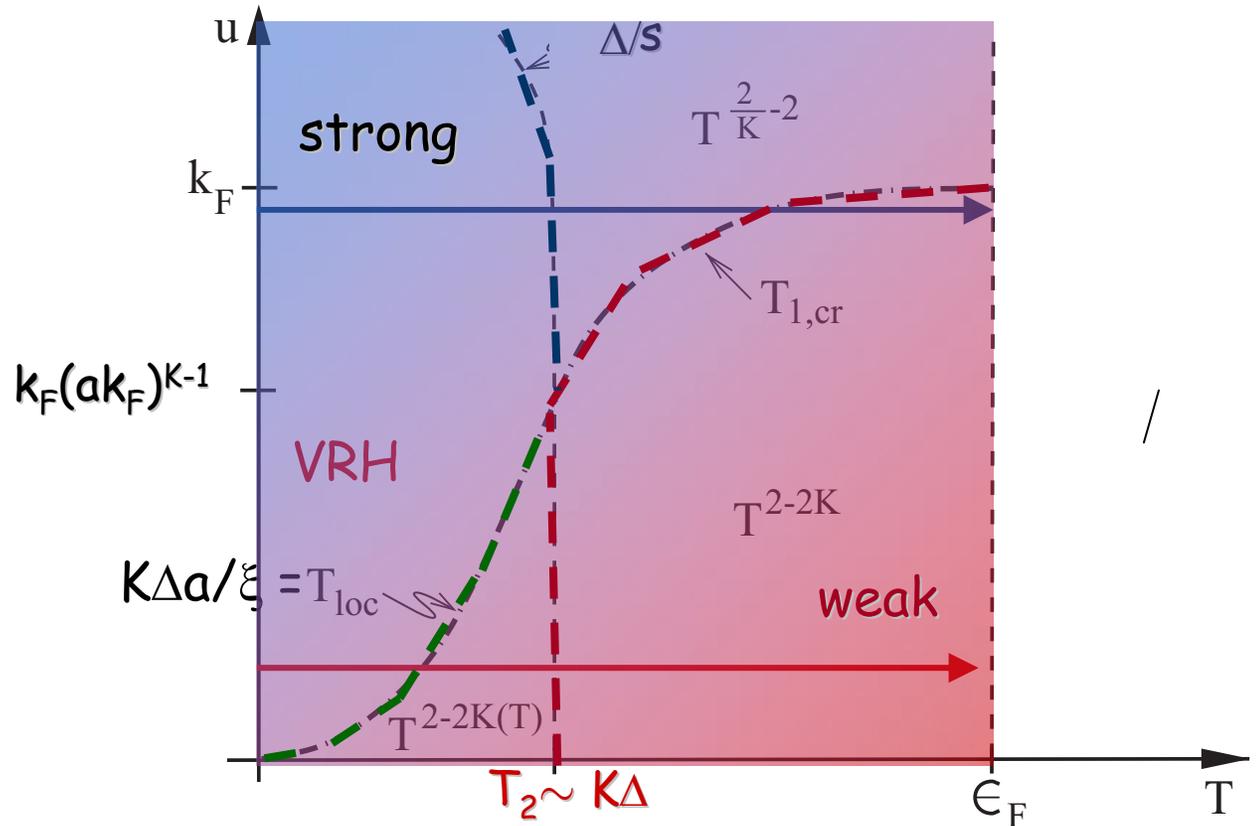
Strong and weak pinning

$T > T_{1,cr}$: single impurity weak

$T < T_2$: collective effects

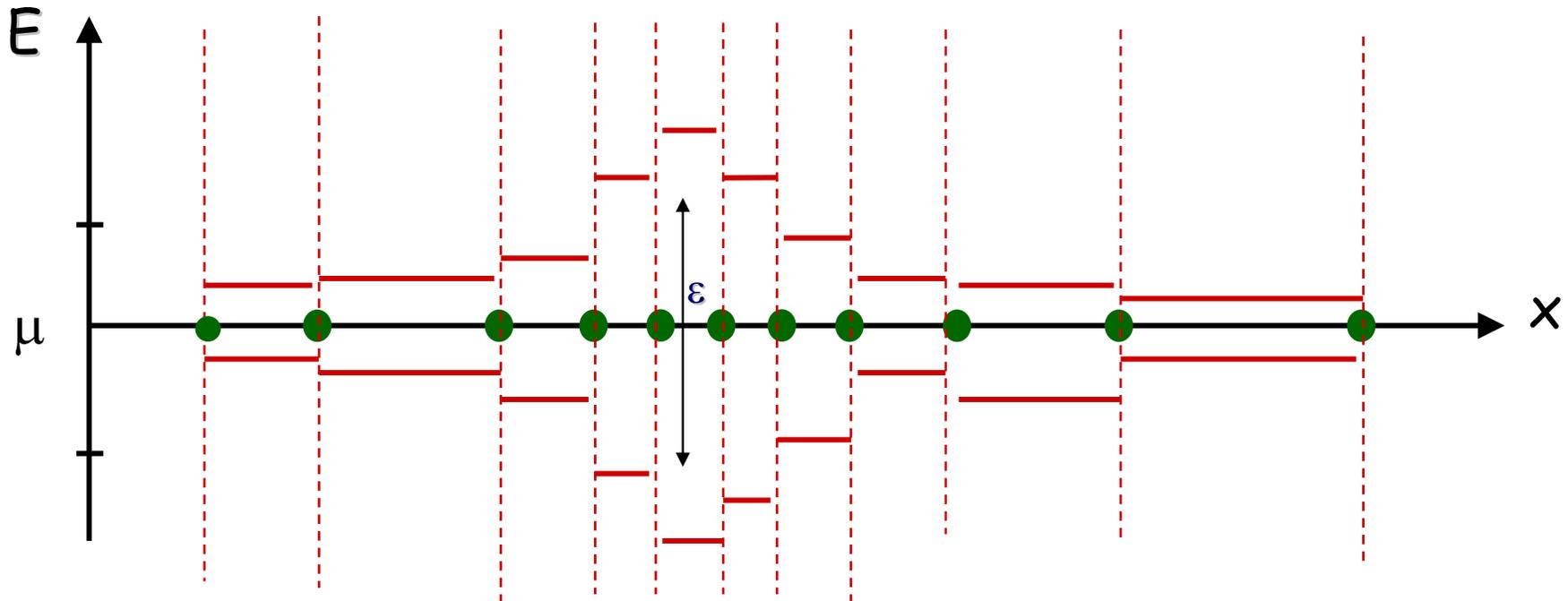


$u < k_F$: SCHA $u \rightarrow u_{eff}$



4. Long wires: rare events

- So far considered: typical quantum dots with $a_i \approx a$
- Now: consider regions with many narrow dots with $a_i \ll a$



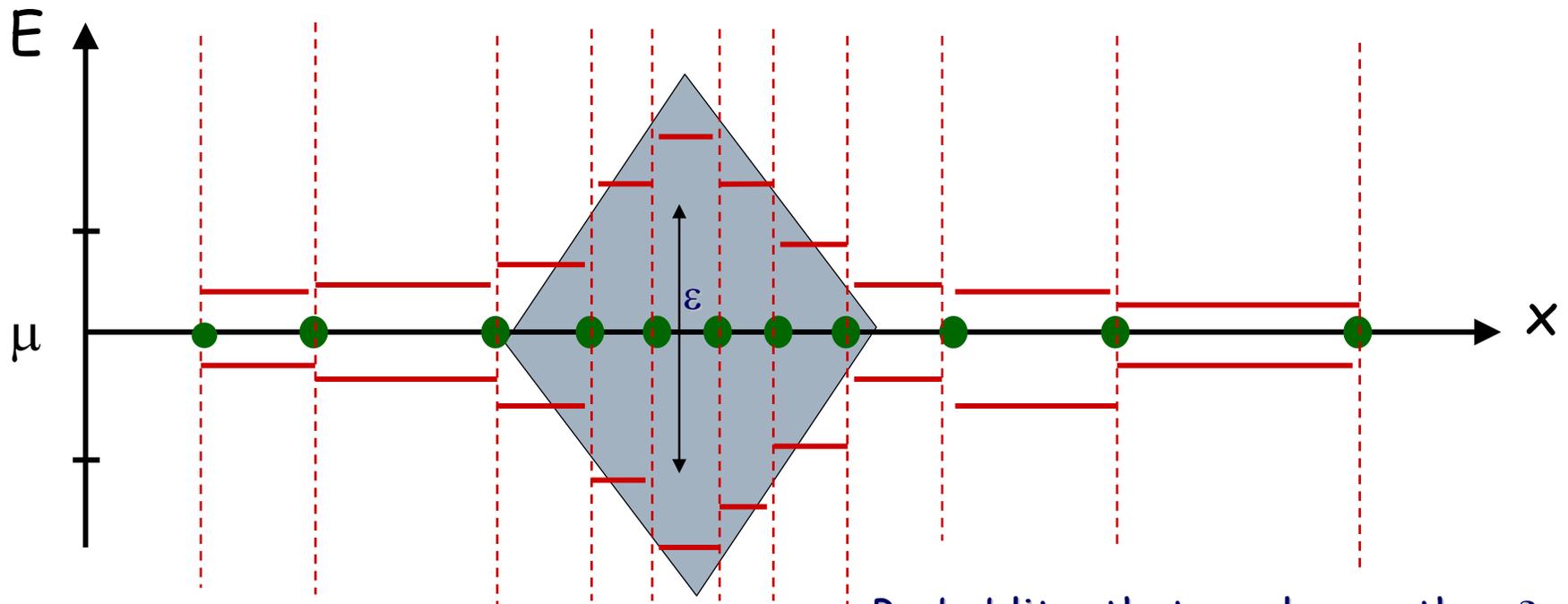
Probability that gap larger than ε

$$\rightarrow \langle \Delta_i \rangle \rightarrow \infty$$

$$P(\varepsilon) = 1 - (\varepsilon/\Delta)(1 - e^{-\Delta/\varepsilon}) \underset{\varepsilon \rightarrow \infty}{\sim} \Delta/(2\varepsilon)$$

4. Long wires: rare events

- So far considered: typical quantum dots with $a_i \approx a$
- Now: consider regions with many narrow dots with $a_i \ll a$



Probability that gap larger than δ

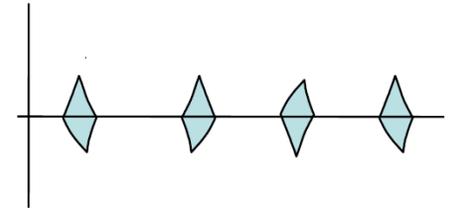
$$P_\epsilon(\epsilon) = 1 - (\epsilon/\Delta)(1 - e^{-\Delta/\epsilon}) \sim \Delta/(2\epsilon)$$

$\epsilon \rightarrow \infty$

“Break” : sequence of narrow dots

Wire: non-overlapping breaks + low resistance connecting pieces

break resistance $R_0 e^u \rightarrow R = L \int P_u(u) R_0 e^u du$



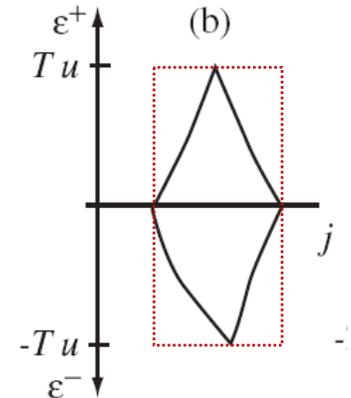
$P_u(u)$: prob. /unit length that break resistance at least e^u

$$I_{jk} \sim e^{-s|j-k|} e^{-E_{jk}/T} \sinh((\xi_j - \xi_k)/T) \quad \xi_j = Fx_j - \mu_j$$

(a) Ohmic break of $|j-k|$ dots

envelope: $E_i(\pm 1) \geq \varepsilon_i^\pm \rightarrow s|j-k| + \max(\varepsilon_j^\pm, \varepsilon_k^\pm)/T \geq u$

simplification: rectangular break: $s|j-k| \sim u, \quad \varepsilon_j^\pm \sim uT$



$$P_u(u) \sim X_{VRH}^{-1} P_\varepsilon(\varepsilon)^{|j-k|} \sim X_{VRH}^{-1} P_\varepsilon(uT)^{u/s} \begin{cases} \ln P_u(u) \sim -u^2 T / \Delta s & \text{if } uT \ll \Delta \\ \ln P_u(u) \approx -u/s \ln(2uT/\Delta) & \text{if } uT \gg \Delta \end{cases}$$

$$\ln P_u(u) \sim -u^2 T / \Delta s \quad \text{if } uT \ll \Delta$$

$$\ln P_u(u) \approx -u/s \ln(2uT/\Delta) \quad \text{if } uT \gg \Delta$$

→ infinite wire:

$$s \ll 1 :$$

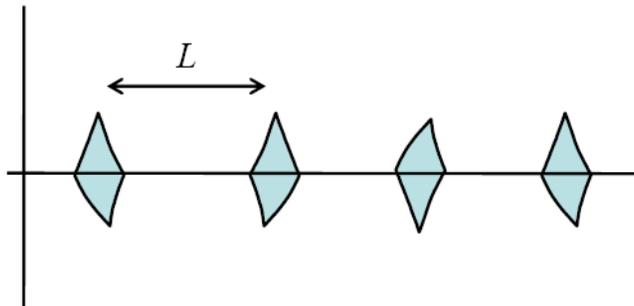
$$\rho \sim \exp(s\Delta/4T)$$

Raikh Ruzin '89

$$s \gg 1 :$$

$$\rho \sim \exp(s\Delta e^{(s-1)}/2T)$$

new



provided $L > a \exp(e^s \Delta (s-1) / Ts)$

→ infinite wire:

Low T, $s \ll 1$:

$$\rho \sim \exp (s\Delta/4T)$$

Raikh Ruzin '89

High T, $s \gg 1$:

$$\rho \sim \exp (s\Delta e^{(s-1)}/2T) \quad \text{new}$$

finite wire: $P_u(u)(L/x_{VRH}) \approx 1 \rightarrow u_{\max}$

$$sT \ln(L/x_{VRH}) \ll \Delta : \quad \rho \sim \exp [s\Delta \ln (L/a) / T]^{1/2} \quad \text{VRH}$$

Raikh Ruzin '89

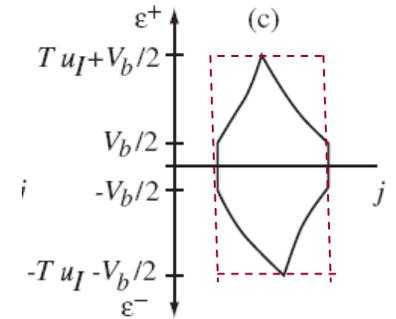
$sT \ln(L/x_{VRH}) \gg \Delta :$

$$\rho \sim \exp [s \ln (L/x_{VRH}) / \ln (Ts/\Delta)] \sim T^\alpha$$

$$\alpha = s \ln (L/x_{VRH}) / \ln^2 (Ts/\Delta)$$

(b) Non-Ohmic breaks of m dots $V_b = \xi_j - \xi_k \gg T$

(main voltage drop across the breaks,
but constant $I = I_0 e^{-u}$ current everywhere)



$$I_{jk} \sim e^{-s|j-k|} e^{-E_{jk}/T} \sinh((\xi_j - \xi_k)/T) \rightarrow s|j-k| + \max(\varepsilon_j^\pm, \varepsilon_k^\pm)/T - V_b/2T \geq u$$

average electric field: $V/L = F = \int dV_b V_b P_V(V_b) = x_{VRH}^{-1} 2Ts (Tu/\Delta)^{-u/s}$

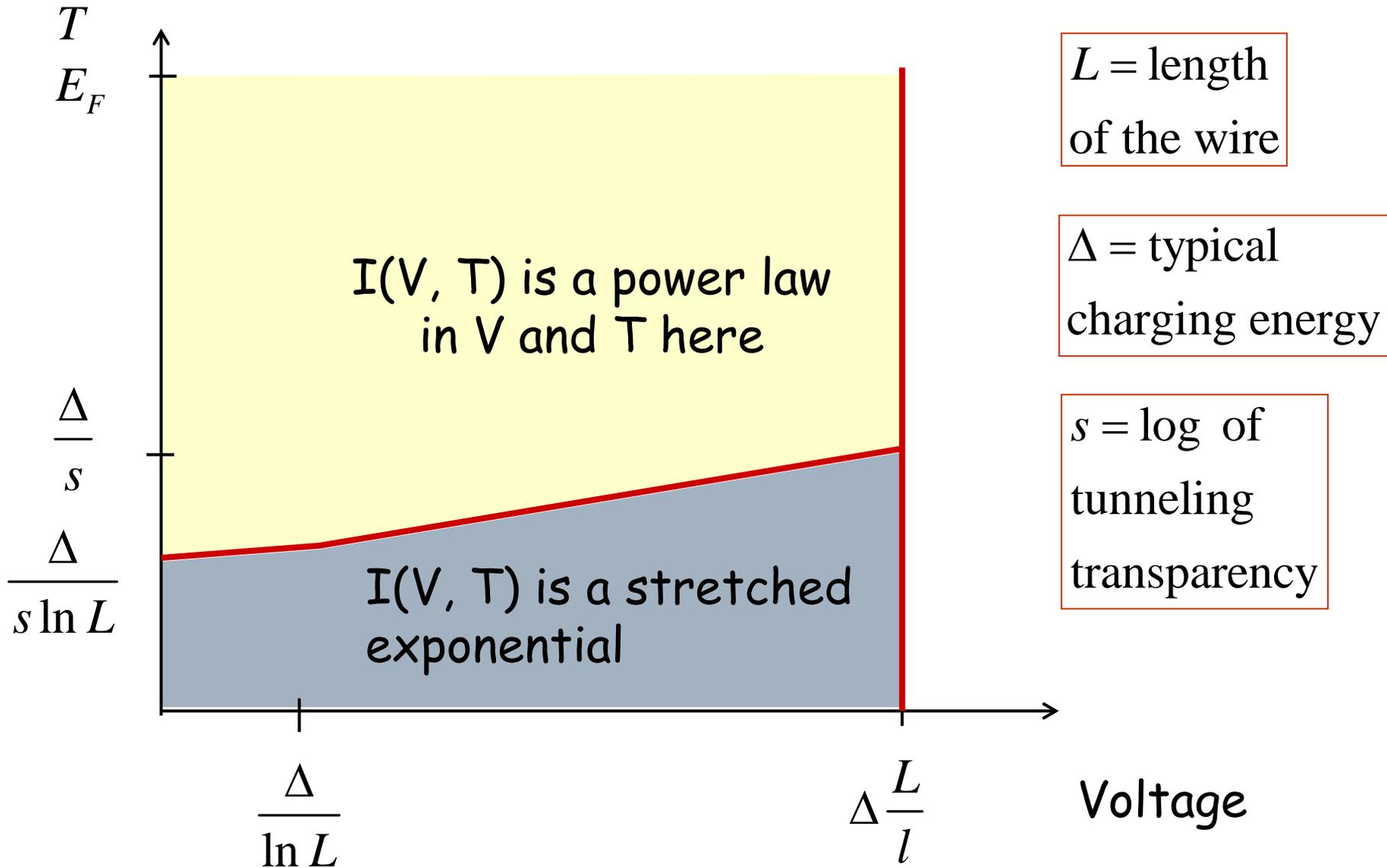
$$P_V(V_b) = x_{VRH}^{-1} [P_\varepsilon(uT + V_b/2)]^{u/s} = x_{VRH}^{-1} (Tu/\Delta)^{-u/s} e^{-V_b/2Ts}$$

$V_b \ll uT$

$$u = -\ln(I/I_0) = s \ln(2Ts/Fx_{VRH}) / \ln(Ts/\Delta)$$

$$I \sim V^\beta, \quad \beta = s / \ln(Ts/\Delta), \quad \alpha/\beta = \ln(L/x_{VRH}) / \ln(Ts/\Delta) > 1$$

Regime diagram



Conclusions:

- linear and non-linear conductivity
- field and temperature cross-over between single and many impurity tunneling
- low field and temperature: Mott-Shklovskii-VRH
- larger E,T: Kane-Fisher - power law behavior
- Kane-Fisher "single-dominant-barrier" theory is not valid in long wires that contains many (> 100 ?) impurities
- true power-law exponents exceed the single-barrier ones by a "large" log-factor (perhaps, by 2 or 3 in practice)!
- resistance is controlled by "difficult spots" - dense clusters of impurities
- global weak/strong pinning regime diagram